


<b>Search Notes</b>  	<b>Application/Control No.</b>  10597150	<b>Applicant(s)/Patent Under Reexamination</b>  SCHOBEN ET AL.
	<b>Examiner</b>  DEVONA E FAULK	<b>Art Unit</b>  2615

SEARCHED			
Class	Subclass	Date	Examiner
381	300,302-309	8/30,3/081	DEF
381	300,302-309	6/18/09,7/1/09	DEF
381	300-309	1/3/2010	DEF
381	300-309	3/13/10	DEF
381	300-309	8/29/10	DEF

SEARCH NOTES		
Search Notes	Date	Examiner
Assignee/inventor search	8/30/08	DEF
combined class/word search	8/30,31/08	DEF
additional search	6/18/09,7/1,2/09	DEF
additonal search	12/29/2009,1/2/2010	DEF
additional search	3/13,15/10	DEF
additional search/ reviewed applicant's arguments, used same prior art	8/29/10	DEF

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
	combined class/word search	3/13,15/10	DEF

	/DEVONA E FAULK/ Primary Examiner.Art Unit 2614
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